

(Following Paper ID and Roll No. to be filled in your Answer Books)

Paper ID : 131613

Roll No.

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**B. TECH.**

**Theory Examination (Semester-VI) 2015-16**

**INTEGRATED CIRCUIT TECHNOLOGY**

**Time : 3 Hours**

**Max. Marks : 100**

**Section-A**

**Q1. Attempt all parts. All parts carry equal marks. Write answer of each part in short. (2×10=20)**

- List the basic process for IC fabrication.
- Explain the purpose of oxidation.
- Compare proximity printing and projection printing.
- What are plasma deposition reactors? Why and how these are used?
- What are the widely used materials for film deposition.
- Explain photomask and photoresist.

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Q3. Attempt any five questions from this section. (10×5=50)

- (a) (i) What is Fick's law of diffusion? Boron is diffused into an n-type single crystal substrate with doping conc. of  $10^{15}$  atm/cm<sup>3</sup>. Assume diffusion function to be Gaussian, if diffusion time is 1hr, surface conc. =  $1 \times 10^{18}$ /cm<sup>3</sup> and depth of junction is 2μm, determine diffusivity.
- (ii) Explain ion implantation and mention its advantages over diffusion.
- (b) Why oxidation is done? Explain the chemistry and kinetics of growth using Deal Groves Model.
- (c) (i) What is latch up? How latch up is avoided in CMOS technology?
- (ii) Describe "Dopant Profiles" in brief.

measurement.

- (f) Explain molecular beam epitaxy in detail. What are its advantages over VPE?
- (g) What are the effects of nesting tolerance on MOSFET layout? Discuss and describe with the help of suitable diagrams.
- (h) Discuss and describe the various process design considerations of VLSI devices.

### Section-C

Attempt any two questions.

(2×15=30)

- Q3. (a) What do you mean by Sputtering? Explain Sputtering Yield. Draw the schematic diagram of signal parallel-plate sputtering system and its working.

- (b) Explain why [www.FirstRanker.com](http://www.FirstRanker.com) is preferred for the deposition of refractory materials like tantalum. [www.FirstRanker.com](http://www.FirstRanker.com)

Q4. (a) Discuss diffusion. Find diffusion constants for :

- (i) Interstitial diffusion
- (ii) Substitutional diffusion

- (b) Give reasons and explain why NPN transistors are preferred over PNP counterparts

Q5. Write short notes on following :

- (a) MOS IC fabrication technique
- (b) Czochralski Process
- (c) CVD process

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